



N-CHANNEL ENHANCEMENT MODE MOSFET

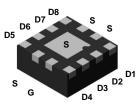
Features

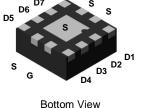
- Low Gate Charge
- $R_{DS(ON)}$: 280m Ω @ V_{GS} = 4.5V (Single MOSFET)
- 8 N-Channel MOSFET in 1 Device
- Common Source
- Small Footprint 1.5mm x 1.5mm
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

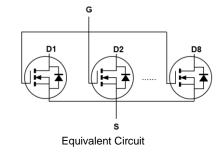
Mechanical Data

- Case: U-QFN1515-12
- Case Material Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208@3
- Terminal Connections: See Diagram
- Weight: 0.004 grams (Approximate)

U-QFN1515-12







Ordering Information (Note 4)

Part Number	Case	Packaging
DMN1250UFEL-7	U-QFN1515-12	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

U-QFN1515-12



A1 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: B = 2014)M = Month (ex: 8 = August)

Date Code Key

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Year	2014		2015	2016		2017	2018		2019	2020		2021
Code	В		С	D		Е	F		G	Н		
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	12	V
Gate-Source Voltage	V _{GSS}	±8	V
Drain Current (Note 6) Continuous $T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	l le	2.0 1.6	А
Pulsed Drain Current (Note 7)	I _{DM}	10	A

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	0.66	W
Total Power Dissipation (Note 6)	P _D	1.25	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	177	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	R _{0JA}	100	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Notes:

- 5. Device mounted on 1"x1", FR-4 PC board with minimum recommended pad layout, and test with single MOSFET. 6. Device mounted on 1"x1", FR-4 PC board with 2 oz. copper, and test with single MOSFET.
- 7. Repetitive Rating, pulse width limited by junction temperature, and test with single MOSFET.

Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
STATIC CHARACTERISTICS							
Drain-Source Breakdown Voltage		12		_	V	$I_D = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}			1	μA	$V_{DS} = 12V, V_{GS} = 0V$	
Gate-Body Leakage Current	I _{GSS}	_	_	±100	nA	$V_{DS} = 0V, V_{GS} = \pm 8V$	
Gate Threshold Voltage	V _{GS(TH)}	0.4	_	1	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance (Note 8)	5	_	280	450	mΩ	$V_{GS} = 4.5V, I_D = 0.2A$	
Static Dialif-Source Off-Resistance (Note 6)	R _{DS(ON)}	_	360	550	mΩ	$V_{GS} = 2.5V, I_D = 0.1A$	
Forward Transfer Admittance	Y _{FS}	_	1	_	S	$V_{DS} = 6V, I_D = 0.2A$	
Diode Forward Voltage (Note 8)	V _{SD}	_	0.8	1.0	V	$I_S = 0.2A$, $V_{GS} = 0V$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		146	190	pF	V 0V V 0V	
Output Capacitance	Coss		10	15	pF	$V_{DS} = 6V, V_{GS} = 0V$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	8	13	pF	1 = 1.0001112	
Gate Resistance	R_{G}	_	2.4	_	Ω	$V_{GS} = 0V$, $V_{DS} = 0V$, $f = 1MHz$	
SWITCHING CHARACTERISTICS (Note 9)							
Total Gate Charge	Qg		1.3	1.9	nC		
Gate-Source Charge	Qgs		0.3	_	nC	$V_{GS} = 4.5V, V_{DS} = 6V, I_{D} = 0.2A$	
Gate-Drain Charge	Q_{gd}	_	0.1	_	nC		
Turn-On Delay Time	t _{D(ON)}	_	1.9	2.7	nS		
Turn-On Rise Time			1.3	_	nS	$V_{DD} = 6V, V_{GS} = 4.5V,$	
Turn-Off Delay Time	t _{D(OFF)}		7.5	11	nS	$R_L = 22\Omega$, $R_G = 6\Omega$	
Turn-Off Fall Time	t _F		1.0	_	nS		

8. Test pulse width t = 300ms, test with single MOSFET. Notes:

^{9.} Guaranteed by design with single MOSFET, not subject to production testing.



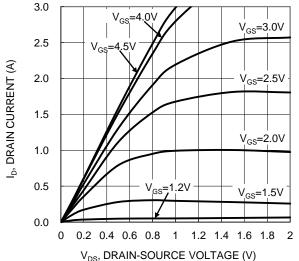


Figure 1. Typical Output Characteristic

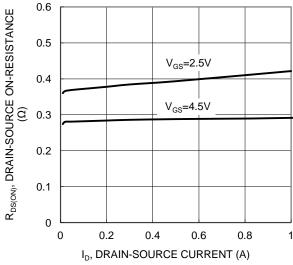


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

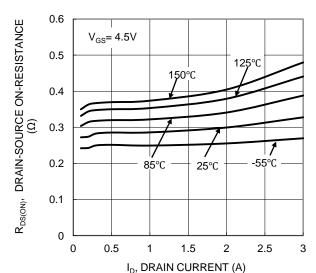
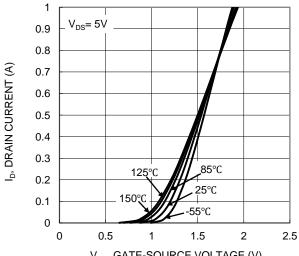


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

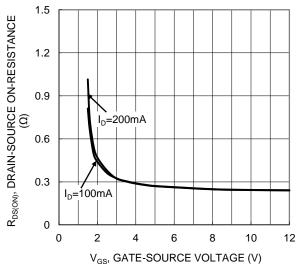


Figure 4. Typical Transfer Characteristic

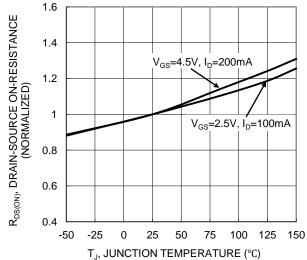


Figure 6. On-Resistance Variation with Temperature



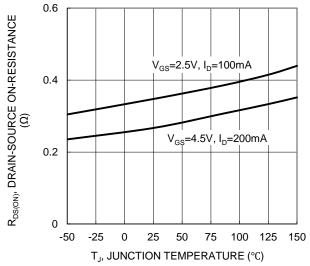
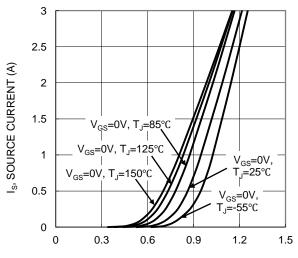
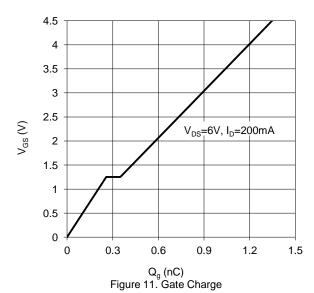


Figure 7. On-Resistance Variation with Temperature

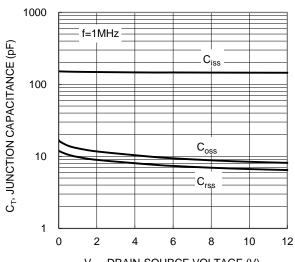


V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current

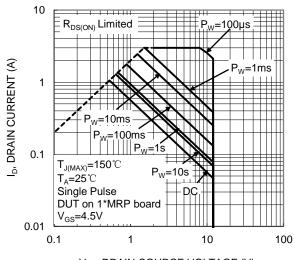


1.2 $V_{GS(TH)}, \, GATE \, THRESHOLD \, VOLTAGE \, (V)$ 1 I_D=1mA 8.0 $I_{D} = 250 \mu A$ 0.6 0.4 0 -50 -25 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature



V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 10. Typical Junction Capacitance

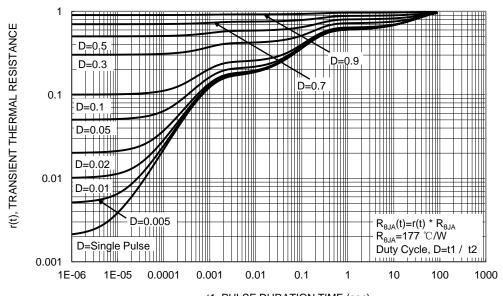


 $V_{\rm DS}$, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area

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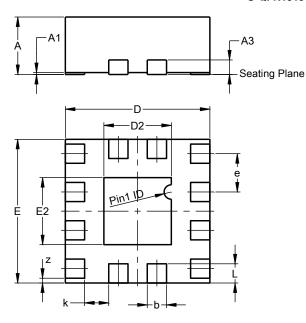
t1, PULSE DURATION TIME (sec) Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

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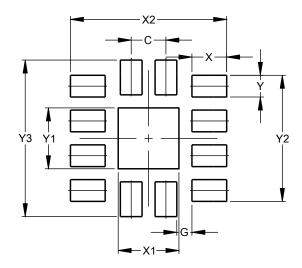


U-QFN1515-12							
Dim	Min	Max	Тур				
Α	0.57	0.63	0.60				
A1	0.00	0.05	0.02				
A3	0.152 BSC						
b	0.15	0.25	0.20				
D	1.45	1.55	1.50				
D2	0.60	0.80	0.70				
Е	1.45	1.55	1.50				
E2	0.60	0.80	0.70				
е	0.40 BSC						
L	0.15	0.25	0.20				
k			0.25				
Z			0.050				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

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Dimensions	Value (in mm)
С	0.400
G	0.175
Х	0.400
X1	0.700
X2	1.800
Y	0.250
Y1	0.700
Y2	1.450
Y3	1 800



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